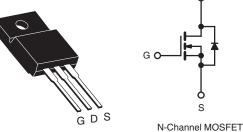




Power MOSFET

PRODUCT SUMMARY					
V _{DS} (V)	250				
R _{DS(on)} (Ω)	$V_{GS} = 10 V$	0.28			
Q _g (Max.) (nC)	68				
Q _{gs} (nC)	11				
Q _{gd} (nC)	35				
Configuration	Single				

TO-220 FULLPAK



FEATURES

- Isolated Package
- High Voltage Isolation = 2.5 kV_{RMS} (t = 60 s; f = 60 Hz)
- RoHS

COMPLIANT

- Sink to Lead Creepage Distance = 4.8 mm
- · Dynamic dV/dt Rating
- · Low Thermal Resistance
- · Lead (Pb)-free Available

DESCRIPTION

Third generation Power MOSFETs from Vishay provide the designer with the best combination of fast switching, ruggedized device design, low on-resistance and cost-effectiveness.

The TO-220 FULLPAK eliminates the need for additional insulating hardware in commercial-industrial applications. The moulding compound used provides a high isolation capability and a low thermal resistance between the tab and external heatsink. The isolation is equivalent to using a 100 micron mica barrier with standard TO-220 product. The FULLPAK is mounted to a heatsink using a single clip or by a single screw fixing.

ORDERING INFORMATION	
Package	TO-220 FULLPAK
Lead (Pb)-free	IRFI644GPbF
	SiHFI644G-E3
SnPb	IRFI644G
	SiHFI644G

S

ABSOLUTE MAXIMUM RATINGS T	_C = 25 °C, u	nless otherw	vise noted			
PARAMETER			SYMBOL	LIMIT	UNIT	
Drain-Source Voltage			V _{DS}	250	- V	
Gate-Source Voltage			V _{GS}	± 20		
Continuous Drain Current	$T_{\rm C} = 25$	T _C = 25 °C	I _D -	7.9		
	VGS AL TO V	V_{GS} at 10 V $T_C = 100 \degree C$		5.0	A	
Pulsed Drain Current ^a			I _{DM}	32	1	
Linear Derating Factor				0.32	W/°C	
Single Pulse Avalanche Energy ^b			E _{AS}	600	mJ	
Repetitive Avalanche Current ^a			I _{AR}	7.9	А	
Repetitive Avalanche Energy ^a			E _{AR}	4.0	mJ	
Maximum Power Dissipation	T _C =	25 °C	PD	40	W	
Peak Diode Recovery dV/dt ^c			dV/dt	4.8	V/ns	
Operating Junction and Storage Temperature Range		T _J , T _{stg}	- 55 to + 150	°C		
Soldering Recommendations (Peak Temperature)	for 10 s			300 ^d		
Mounting Torque	6-32 or M3 screw			10	lbf ⋅ in	
				1.1	N · m	

Notes

a. Repetitive rating; pulse width limited by maximum junction temperature (see fig. 11).

- b. $V_{DD} = 50$ V, starting $T_J = 25$ °C, L = 15 mH, $R_G = 25 \Omega$, $I_{AS} = 7.9$ A (see fig. 12).
- c. $I_{SD} \le 7.9$ A, dI/dt ≤ 150 A/µs, $V_{DD} \le V_{DS}$, $T_J \le 150$ °C.

d. 1.6 mm from case.

^{*} Pb containing terminations are not RoHS compliant, exemptions may apply



PARAMETER	SYMBOL	TYP		MAX.			UNIT	
Maximum Junction-to-Ambient	R _{thJA}	- 65 - 3.1			- °C/W			
Maximum Junction-to-Case (Drain)	R _{thJC}							
Maximum ouncilor to Case (Drain)	"thJC							
SPECIFICATIONS T _J = 25 °C, 0	unless otherw	vise noted						
PARAMETER	SYMBOL	TES	T CONDITI	ONS	MIN.	TYP.	MAX.	UNIT
Static								
Drain-Source Breakdown Voltage	V _{DS}	V _{GS} =	= 0 V, I _D = 2	50 µA	250	-	-	V
V _{DS} Temperature Coefficient	$\Delta V_{DS}/T_J$	Reference	ce to 25 °C,	I _D = 1 mA	-	0.34	-	V/°C
Gate-Source Threshold Voltage	V _{GS(th)}	V _{DS} =	= V _{GS} , I _D = 2	250 μA	2.0	-	4.0	V
Gate-Source Leakage	I _{GSS}	,	V _{GS} = ± 20 '	V	-	-	± 100	nA
Zero Gate Voltage Drain Current		V _{DS} =	V _{DS} = 250 V, V _{GS} = 0 V			-	25	
	IDSS	V _{DS} = 200 V	/, V _{GS} = 0 V	, T _J = 125 °C	-	-	μA 250	
Drain-Source On-State Resistance	R _{DS(on)}	V _{GS} = 10 V	I _D	= 4.7 A ^b	-	-	0.28	Ω
Forward Transconductance	9 _{fs}	V _{DS} =	= 50 V, I _D =	4.7 A ^b	6.0	-	-	S
Dynamic								
Input Capacitance	C _{iss}	N 0.1			-	1300	-	pF
Output Capacitance	C _{oss}	$V_{GS} = 0 V, V_{DS} = 25 V, f = 1.0 MHz, see fig. 5 f = 1.0 MHz$		-	330	-		
Reverse Transfer Capacitance	C _{rss}			-	85	-		
Drain to Sink Capacitance	С			2	-	12	-	1
Total Gate Charge	Qg			-	-	68		
Gate-Source Charge	Q _{gs}	V _{GS} = 10 V		$V.9 \text{ A}, V_{\text{DS}} = 200 \text{ V},$	-	-	11	nC
Gate-Drain Charge	Q _{gd}	_	see fig. 6 and 13 ^b		-	-	35	
Turn-On Delay Time	t _{d(on)}				-	11	-	
Rise Time	t _r		= 125 V, I _D =		-	24	-	1
Turn-Off Delay Time	t _{d(off)}	$R_G = 9.1 \Omega$, $R_D = 16 \Omega$, see fig. 10^b		-	53	-	ns	
Fall Time	t _f	-	see lig. To		-	24	-	1
Internal Drain Inductance	L _D	Between lead, 6 mm (0.25") from package and center of die contact		-	4.5	-	nH	
Internal Source Inductance	L _S			-	7.5	-		
Drain-Source Body Diode Characteristic	s	1						
Continuous Source-Drain Diode Current	I _S	showing the			-	-	7.9	A
Pulsed Diode Forward Current ^a	I _{SM}	p - n junction diode			-	-	32	~
Body Diode Voltage	V_{SD}	T_J = 25 °C, I_S = 7.9 A, V_{GS} = 0 V ^b		-	-	1.8	V	
Body Diode Reverse Recovery Time	t _{rr}	$T_J = 25 \text{ °C}, I_F = 7.9 \text{ A}, dl/dt = 100 \text{ A}/\mu\text{s}^b$		-	250	500	ns	
Body Diode Reverse Recovery Charge	Q _{rr}			-	2.3	4.6	μC	
Forward Turn-On Time	t _{on}	Intrinsic turn-on time is negligible (turn-on is dominated by L_S and L_C						D)

Notes

a. Repetitive rating; pulse width limited by maximum junction temperature (see fig. 11).

b. Pulse width \leq 300 µs; duty cycle \leq 2 %.





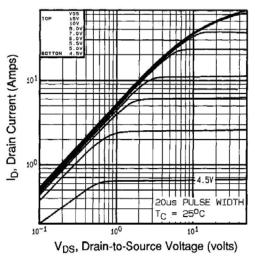


Fig. 1 - Typical Output Characteristics, T_C = 25 °C

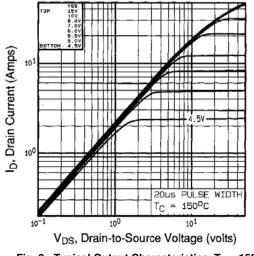
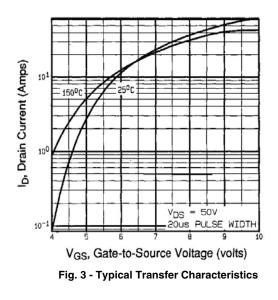


Fig. 2 - Typical Output Characteristics, $T_C = 150$ °C



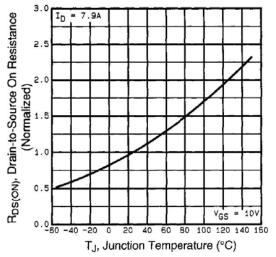


Fig. 4 - Normalized On-Resistance vs. Temperature

IRFI644G, SiHFI644G

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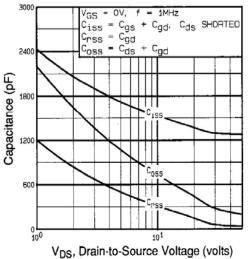


Fig. 5 - Typical Capacitance vs. Drain-to-Source Voltage

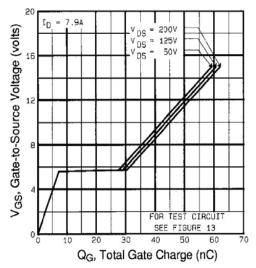
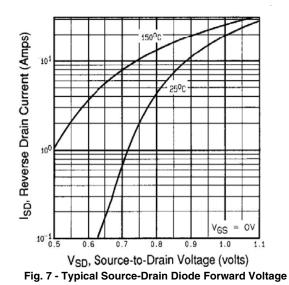
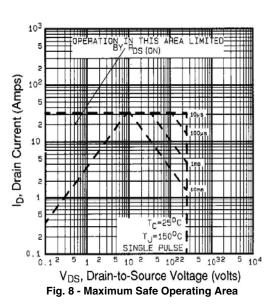


Fig. 6 - Typical Gate Charge vs. Gate-to-Source Voltage







IRFI644G, SiHFI644G

Vishay Siliconix

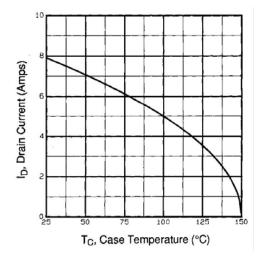


Fig. 9 - Maximum Drain Current vs. Case Temperature

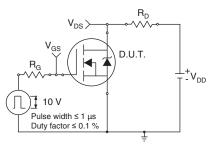


Fig. 10a - Switching Time Test Circuit

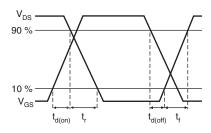
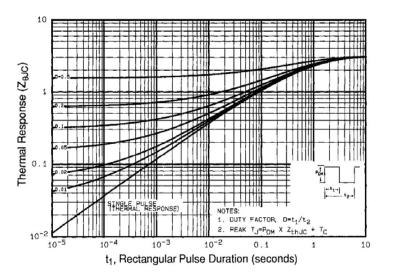


Fig. 10b - Switching Time Waveforms





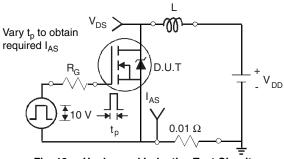


Fig. 12a - Unclamped Inductive Test Circuit

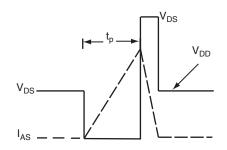


Fig. 12b - Unclamped Inductive Waveforms

IRFI644G, SiHFI644G

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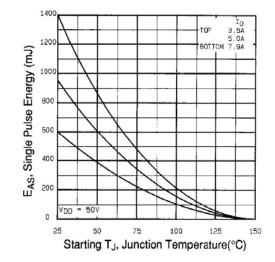


Fig. 12c - Maximum Avalanche Energy vs. Drain Current

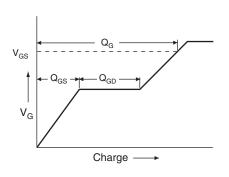
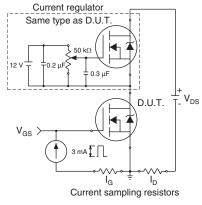
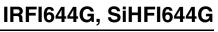


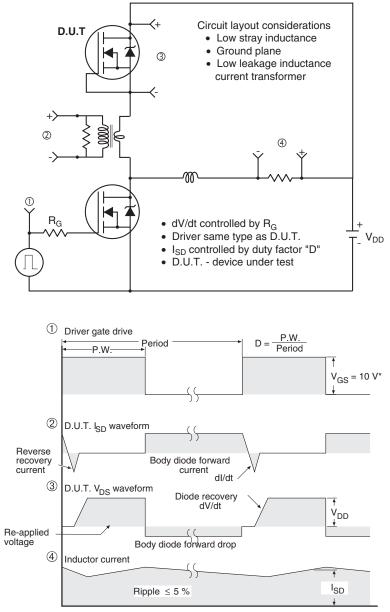
Fig. 13a - Basic Gate Charge Waveform











Peak Diode Recovery dV/dt Test Circuit

* $V_{GS} = 5$ V for logic level devices

Fig. 14 - For N-Channel

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